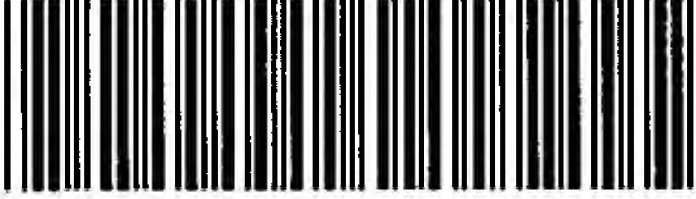





<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under R xamination	
	09/994,279	CHIANG ET AL.	
	Examiner	Art Unit	
	David Nhu	2818	

SEARCHED			
Class	Subclass	Date	Examiner
438	475	2/2/2005	DN
	216		
	485		
	677, 692		
	680, 681		
	710, 714		
	745, 758		
	706		
	905, 906		
	935		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
SEARCHED IN EAST	2/2/2005	DN